

# Agilent 660/670/680 Series FTIR

The world's best FTIR

## **Specifications**



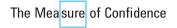
#### **Design overview**

The Agilent 660 FTIR spectrometer design is based on a 38 mm dynamically aligned, 60° mechanical bearing Michelson interferometer and is capable of covering the widest spectral range down to 20 cm<sup>-1</sup>. The Agilent 660 FTIR guarantees better than 0.075 cm<sup>-1</sup> maximum resolution, and includes a revolutionary air-cooled source capable of delivering more than 50 mW of power to the sample. The Agilent 660 FTIR can also be upgraded to a 670 or 680 FTIR, providing you with maximum flexibility as your FTIR needs change.

The Agilent 670 and 680 FTIR incorporate a 57 mm dynamically aligned, 60° air bearing Michelson interferometer covering the widest spectral range down to 10 cm<sup>-1</sup>. Both spectrometer models come with the high-throughput air-cooled source, delivering over four times greater sensitivity that any other available FTIR spectrometer. The Agilent 670 FTIR is a rapid scan spectrometer that can be upgraded to the step-scan Agilent 680 FTIR system.

The 660/670/680 Series FTIR are compatible with a wide range of accessories. These include single point microscopy, microscopy imaging, macro imaging, ATR imaging, PAS, PM-IRRAS,  $\mu$ s and nsTRS and hyphenated techniques such as GC-IR, GPC-IR and TGA-IR.

Agilent FTIR spectrometers are manufactured according to a quality management system certified to ISO 9001.





#### **Performance specifications**

Туре	660 FTIR	670 FTIR	680 FTIR
Interferometer type	38 mm dynamically aligned, 60° mechanical bearing Michelson	57 mm dynamically aligned, 60° air bearing Michelson	57 mm dynamically aligned, 60° air bearing Michelson
Spectral range (cm <sup>-1</sup> ) <sup>1</sup>			
Standard	Mid IR: 9,000–375	Mid IR: 9,000–375	Mid IR: 9,000–375
Optional	53,000–20	53,000–10	53,000–10
Spectral resolution (cm <sup>-1</sup> )			
Typical	Better than 0.06	Better than 0.06	Better than 0.06
Guaranteed	Better than 0.075	Better than 0.075	Better than 0.075
Signal-to-noise ratio <sup>2</sup>			
Guaranteed 5 sec p-p	>10,000:1 p-p	>12,000:1 p-p with 75% beam attenuation	>12,000:1 p-p with 75% beam attenuation <sup>3</sup>
Typical 5 sec p-p	>16,000:1 p-p	>17,500:1 p-p with 75% beam attenuation	>17,500:1 p-p with 75% beam attenuation
Typical 5 sec p-p with ATR	>4,500:1 p-p	>12,000:1 p-p	>12,000:1 p-p
Typical 1 min p-p	>50,000:1 p-p	>50,000:1 p-p with 75% beam attenuation	>50,000:1 p-p with 75% beam attenuation
Typical 1 min RMS	>210,000:1	>215,000:1 with 75% beam attenuation	>215,000:1 with 75% beam attenuation
Infrared power (at the sample focus)	>50 mW	>160 mW	>160 mW
Wavenumber			
Wavenumber accuracy	0.005 cm <sup>-1</sup> at 2200 cm <sup>-1</sup>	0.005 cm <sup>-1</sup> at 2200 cm <sup>-1</sup>	0.005 cm <sup>-1</sup> at 2200 cm <sup>-1</sup>
Wavenumber precision	0.003 cm <sup>-1</sup>	0.002 cm <sup>-1</sup>	0.002 cm <sup>-1</sup>
Photometric performance			
Ordinate linearity DLaTGS (Deviation from 0%T based on ASTM1421)	Better than 0.06%T	Better than 0.06%T	Better than 0.06%T
Ordinate linearity, linearized MCT (Deviation from 1.60 Abs polystyrene peak at 2920 cm <sup>-1</sup> )	Better than 0.10 Abs	Better than 0.10 Abs	Better than 0.10 Abs
Kinetics scan rates			
Standard (16 $\text{cm}^{-1}$ spectral resolution)	>40 spectra/second	>110 spectra/second (Better than 10 ms/spectra)	>110 spectra/second (Better than 10 ms/spectra)
Optional (16 cm <sup>-1</sup> spectral resolution)	>70 spectra/second		
Time resolved spectroscopy			1.07
µs sampling rate	Upgrade	Upgrade	1.67 µs
ns sampling rate	Upgrade	Upgrade	1 ns

#### **Performance specifications**

660 FTIR	670 FTIR	680 FTIR
Sealed and dessicated	Purged	Purged
Purged or tropical (moisture- resistant windows)	N/A	N/A
Delta-Sigma, 24 bit, 600 kHz (Dual ADC optional)	Delta-Sigma, 24 bit, 600 kHz (Dual ADC standard)	Delta-Sigma, 24 bit, 600 kHz (Dual ADC standard)
USB 2	USB 2	USB 2
3 (left, right and rear emission)	3 (left, right and rear emission)	3 (left, right and rear emission)
Yes, to 670 or 680 FTIR	Yes, to 680 FTIR	N/A
Upgrade	Upgrade	Yes (DSP1, 2 and 3) • PM-IRRAS <sup>₄</sup>
		<ul> <li>Polymer stretching</li> </ul>
		<ul> <li>µs Time Resolved Spectroscopy (TRS)</li> <li>ns Time Resolved Spectroscopy (TRS)</li> <li>Simultaneous multidepth profiling using PAS<sup>4</sup></li> </ul>
	Sealed and dessicated Purged or tropical (moisture- resistant windows) Delta-Sigma, 24 bit, 600 kHz (Dual ADC optional) USB 2 3 (left, right and rear emission) Yes, to 670 or 680 FTIR	Sealed and dessicated Purged or tropical (moisture- resistant windows)Purged N/ADelta-Sigma, 24 bit, 600 kHz (Dual ADC optional) USB 2Delta-Sigma, 24 bit, 600 kHz (Dual ADC standard) USB 23 (left, right and rear emission)3 (left, right and rear emission)Yes, to 670 or 680 FTIRYes, to 680 FTIR

#### **Physical specifications**

Туре	660 FTIR	670 FTIR	680 FTIR
Sample compartment dimensions (W x D x H)	23.2 x 27.6 x 15.4 cm	23.2 x 27.6 x 15.4 cm	23.2 x 27.6 x 15.4 cm
	(9.1 x 10.9 x 6.1 in.)	(9.1 x 10.9 x 6.1 in.)	(9.1 x 10.9 x 6.1 in.)
Spectrometer dimensions (W x D x H)	70.8 x 75.6 x 34.4 cm	70.8 x 75.6 x 34.4 cm	70.8 x 75.6 x 34.4 cm
	(27.9 x 29.8 x 13.5 in)	(27.9 x 29.8 x 13.5 in)	(27.9 x 29.8 x 13.5 in)
Weight	80 kg (176 pounds)	80 kg (176 pounds)	80 kg (176 pounds)

### Configurations

Standard system configurations <sup>5</sup>	Range (cm <sup>-1</sup> ) <sup>6</sup>	Source(s)	Beamsplitter(s)	Detector(s)
Mid-IR Near-IR	9,000–375 15,800–2,800	Ceramic Tungsten-halogen	Extended range KBr NIR quartz	Cooled DLaTGS PbSe
Mid-Near IR (dual)	15,800–375	Ceramic, tungsten- halogen	Extended range KBr/ NIR quartz	Cooled DLaTGS/PbSe
Mid-Far IR	6,000–225	Ceramic	CsI	Cooled DLaTGS
Far-IR	700–10	Ceramic or Hg-arc	Mylar	Far-IR DLaTGS or Bolometer <sup>7</sup>
Vis	25,000-8,600	Xenon/Tungsten halogen	UV quartz	Silicon
UV-Vis	53,000–12,000	Deuterium	UV quartz	PMT
Configurable options	Туре		Spectral range (cm <sup>-1</sup> )	
Sources (Single or dual source assemblies available)	Ceramic air-cooled Tungsten halogen sourc Hg-Arc (external) Xenon (external) Deuterium (external)	e	Mid-IR: 9,000–20 Vis-Near-IR: 25,000–2,1 Far-IR: 600–10 UV-Visible: 40,000–10,00 UV: 53,000–12,000	
<b>Beamsplitters</b> (With internal storage for 2 extra beamsplitters)	Extended range KBr CsI NIR quartz UV-Vis quartz CaF <sub>2</sub> Set of 5 Mylar ( 6.25, 12	.5, 25, 50 and 125 μm)	11,000–375 6,000–225 20,000–2,800 53,000–4,000 18,000–1,200 700–10	
<b>Detectors</b> (Single or dual detector assemblies available)	Cooled/ambient DLaTG MCT detectors Linearized MCT detecto Far-IR DLaTGS Lead selenide (PbSe) Silicon Far-IR bolometer <sup>7</sup> PMT: R446	-	18,000–150 12,000–450 12,000–450 700–20 15,800–2,000 25,000–8,600 600–10 54,000–11,500 (185–870	I nm)

# Agilent 660/670/680 Series FTIR

Accession		
Accessories	Туре	Specification
		ries FTIR are compatible with sample compartment accessories from all ers and uses Accessory Recognition Technology (ART).
	Major accessories	610 Microscope
	include	620 Microscope
		Focal Plane Array (FPA) chemical imaging
		Large Sample (LS) accessory for macro imaging
		External sample compartment
		GC-IR accessory
		GPC-IR
Sunnart naliaiae		
Support policies	Туре	Policy
Support policies	Type Warranty	<b>Policy</b> 12 months, though this may vary according to location.
Support policies		,
Support policies	Warranty	12 months, though this may vary according to location. Seven (7) years from date of last unit manufacture. After this time,
Support policies Further details	Warranty Hardware support period	12 months, though this may vary according to location. Seven (7) years from date of last unit manufacture. After this time, parts and supplies will be provided if available.

The represents only an approximate range based on a configuration with Mid IR source, KBr beamsplitter and DLaTGS detector.
 Measured as peak-to-peak, between 2,200 and 2,100 cm<sup>-1</sup> under a standard configuration with 4 cm<sup>-1</sup> spectral resolution. The ATR measurement is made using a single bounce, diamond ATR accessory and the peak-to-peak signal-to-noise ratio is calculated between 2,800 and 2,700 cm<sup>-1</sup>.
 75% beam attenuation is required, as under 'open beam' conditions the detector is saturated due to too much energy.
 Rapid scan options available for the 660 and 670 FTIR.
 Ther configurations may be available.
 This represents only an approximate range based on the configuration of components shown in the table. Other combinations components may alter this range.
 Bolometer is only available on the 670/680 FTIR.

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